

Current suppressing effect in alloy metal and 6H-SiC substrate Schottky contacts

Rang, Toomas; Blum, Alfons BEC'96 : the 5th Biennial Baltic Electronics Conference, October 7-11, 1996, Tallinn, Estonia : proceedings 1996 / p. 81-84: ill

Elements of noise modeling in bipolar semiconductor devices

Blum, Alfons BEC : Baltic Electronics Conference : proceedings of the 4th Biennial Conference, October 9-14, 1994, Tallinn (Estonia). 1 1994 / p. 11-27

Interfaces to 6H-SiC substrates - technology and simulation

Rang, Toomas; Blum, Alfons Proceedings of the Estonian Academy of Sciences. Engineering 1997 / 4, p. 250-259: ill

Phase noise in oscillators - numerical calculations by SPICE

Irscheid, Omar; Blum, Alfons BEC'96 : the 5th Biennial Baltic Electronics Conference, October 7-11, 1996, Tallinn, Estonia : proceedings 1996 / p. 319-322: ill

Temperature effects in alloy metal and 6H-SiC substrate Schottky contacts caused by the current suppressing effect

Rang, Toomas; Blum, Alfons Proceedings of the International Conference and Exhibition Micro Materials : MicroMat '97, April 16-18, 1997, Berlin, Germany 1997 / p. 591-596

Two dimensional modelling of alloy metal Schottky contacts to 6H-SiC substrate

Rang, Toomas; Blum, Alfons Proceedings of the ELECTROSOFT 96, May 28-30, San-Miniato, Italy 1996 / p. 347-356